


<b>Search Notes</b>  	<b>Application/Control No.</b>  10578960	<b>Applicant(s)/Patent Under Reexamination</b>  MINIXHOFER, RAINER
	<b>Examiner</b>  ROBERT HUBER	<b>Art Unit</b>  2892

SEARCHED			
Class	Subclass	Date	Examiner
257	432	3/5/08	Robert Huber
257	438, 461, 431, 464, 414	3/4/08	Robert Huber
257	440	8/7/08	RH
257	E31.032, E31.038	10/22/09	RH
438	69, 70, 74	10/22/09	RH

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search - EAST (USOCR, USPAT, USPGPUB) - See Printout	3/4/08	Robert Huber
PLUS Search - Keywords: optoelectronic, zone, plate, semiconductor, silicon, oxide, nitride, detection, region, visible, light, diffraction, diffractive, fresnel, transistion, interface, dopant, radiation, metal	3/4/08	Robert Huber
EAST Search (USOCR, USPAT, USPGPUB, FPRS, EPO, JPO, DERWENT, IBM) - See Printout	3/4/08 - 3/5/08	Robert Huber
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	8/7/08	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	1/7/08	RH
Updated EAST search (USPAT, USPGPUB, USOCR, FPRS, EPO, JPO, DERWENT, IBM) - see printout	10/22/09	RH
.clm. searh - EAST (USPAT, USPGPUB, USOCR, USPAD) - see printout	10/22/09	RH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	438, 440,464, 431,432, 461, E31.032, E31.038	10/22/09	RH
438	69, 70, 74	10/22/09	RH

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